

# A H+) N&' N-Channel Power<sup>®</sup> MOSFET 75V, 2') A, $3.2m\Omega$

# **Features**

- $R_{DS(on)} = 2.5 m\Omega$  (Typ.)@  $V_{GS} = 10 V$ ,  $I_{D} = 75 A$
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extremely Low  $R_{DS(on)}$
- · High Power and Current Handling Capability
- · RoHS Compliant

# **Description**

This N-Channel MOSFET is produced using { [ • E^\&@Semiconductor's adcanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

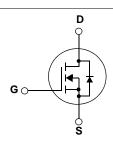
# **Application**

• DC to DC Convertors / Synchronous Rectification









# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

GDS

Symbol		Parameter		'A H+) N&' ·····	Units
V <sub>DSS</sub>	Drain to Source Voltage			75	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
		-Continuous (T <sub>C</sub> = 25°C, Silicon Lin	nited)	235*	
I <sub>D</sub>	Drain Current -Continuous (T <sub>C</sub> = 100°C, Silicon Limited)		mited)	165*	Α
		-Continuous (T <sub>C</sub> = 25°C, Package I	imited)	120	
DM	Drain Current	- Pulsed	(Note 1)	940	А
-AS	Single Pulsed Avalanche	Energy	(Note 2)	1995	mJ
dv/dt	Peak Diode Recovery dv/o	dt	(Note 3)	5.5	V/ns
<b>1</b>	Dower Dissination	$(T_C = 25^{\circ}C)$		375	W
$P_{D}$	Power Dissipation  - Derate above 25°C			2.5	W/°C
Γ <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Te	Temperature Range		-55 to +175	οС
Γ <sub>L</sub>	Maximum Lead Temperate 1/8" from Case for 5 Seco	ure for Soldering Purpose, nds		300	°C

<sup>\*</sup>Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

## **Thermal Characteristics**

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.4	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.24	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	

# Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
ÁT VÏ Í NGHÁWWWW	HÐ⊄ÌÏV T∰∰∰	<b>⋘</b> ТО-3₽ <b>⋘</b>	<b>/////////////////////////////////////</b>	**************************************	08/////////////////////////////////////

## **Electrical Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_C = 25^{\circ} C$	75	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.05	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 75V, V_{GS} = 0V$	-	-	1	^
		$V_{DS} = 75V, T_C = 150^{\circ}C$	-	-	500	μΑ
$I_{GSS}$	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.5	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	-	2.5	3.2	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20V, I_D = 75A$ (Note 4)	-	180	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	11400	15160	pF
C <sub>oss</sub>	Output Capacitance			-	1360	1810	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/12		-	595	800	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V			-	169	220	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		$V_{DS} = 60V, I_{D} = 75A$	-	60	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V	(Note 4, 5)	=	47	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	230	470	ns
t <sub>r</sub>		$V_{DD} = 37.5V, I_D = 75A$	-	191	392	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{GEN} = 25\Omega$ , $V_{GS} = 10V$	-	335	680	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)	-	121	252	ns

### **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current			-	235	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	940	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 75A$	-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 75A	-	53	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s   (No.4)$	ote 4) -	77	-	nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.71mH,  $I_{AS}$  = 75A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C
- 3.  $I_{SD} \le 75 \text{A}$ , di/dt  $\le 200 \text{A}/\mu\text{s}$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width  $\leq 300 \mu s, \, \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

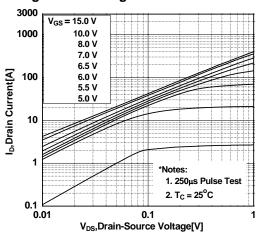


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

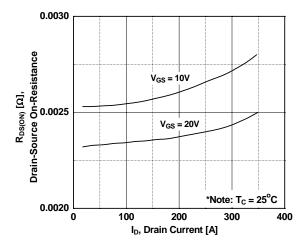


Figure 5. Capacitance Characteristics

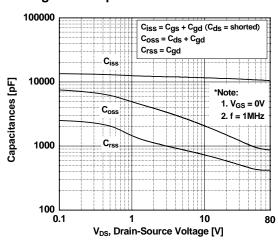


Figure 2. Transfer Characteristics

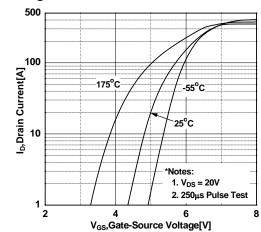


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

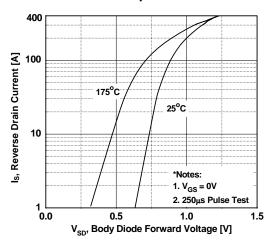
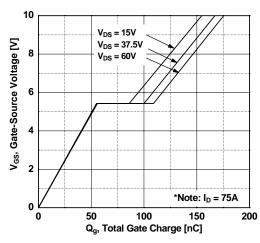


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics (Continued)**

Figure 7. Breakdown Voltage Variation vs. Temperature

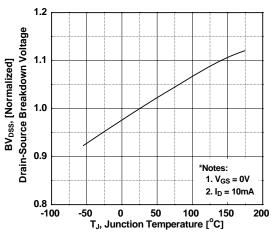


Figure 8. On-Resistance Variation vs. Temperature

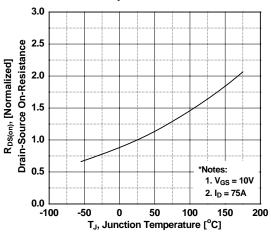


Figure 9. Maximum Safe Operating Area

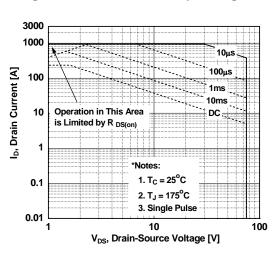


Figure 10. Maximum Drain Current vs. Case Temperature

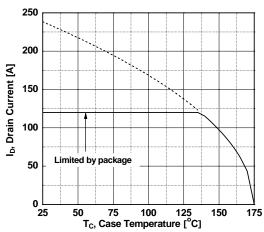
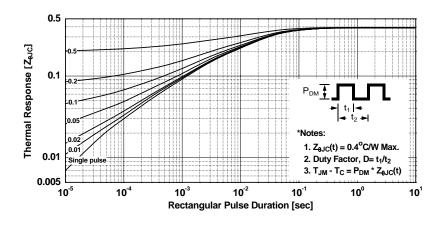
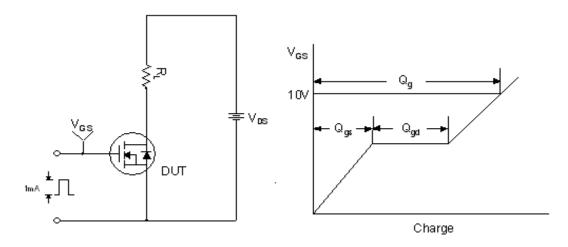


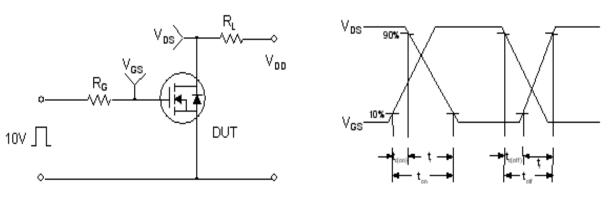
Figure 11. Transient Thermal Response Curve



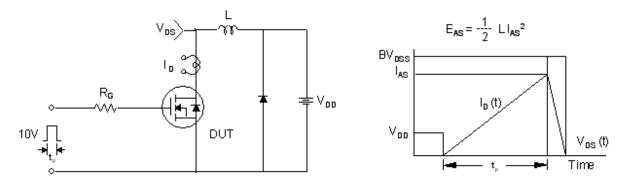
# **Gate Charge Test Circuit & Waveform**



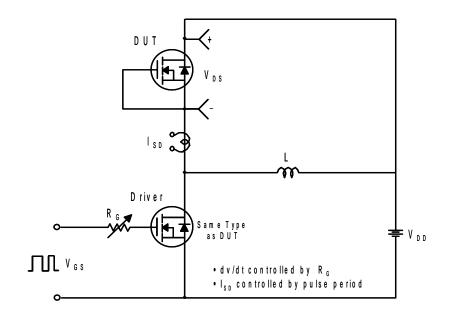
## **Resistive Switching Test Circuit & Waveforms**

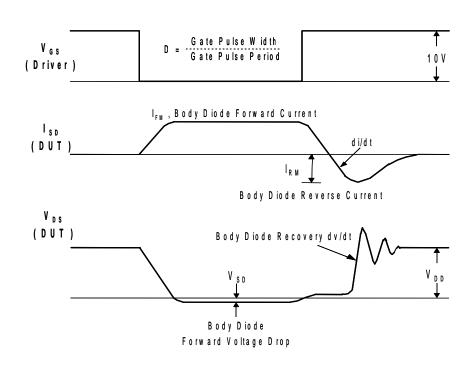


**Unclamped Inductive Switching Test Circuit & Waveforms** 



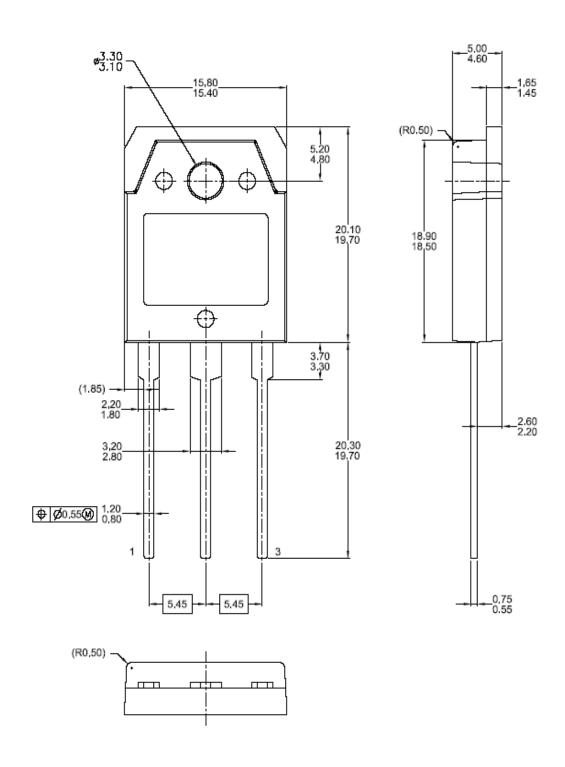
### Peak Diode Recovery dv/dt Test Circuit & Waveforms





# **Mechanical Dimensions**

**TO-3P** 



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